TOSHIBA CMOS DIGITAL INTEGRATED CIRCUIT SILICON MONOLITHIC

TC74HC367AP, TC74HC367AF, TC74HC367AFN TC74HC368AP, TC74HC368AF, TC74HC368AFN

HEX BUS BUFFER
TC74HC367AP/AF/AFN NON-INVERTED (3-STATE)
TC74HC368AP/AF/AFN INVERTED (3-STATE)

The TC74HC367A and TC74HC368A are high speed CMOS 3 - STATE BUS BUFFERs fabricated with silicon gate C2MOS technology.

They achieve the high speed operation similar to equivalent LSTTL while maintaining the CMOS low power dissipation.

They contain six buffers; four buffers are controlled by an enable input $(\overline{G}1)$, and the other two buffers are controlled by another enable input $(\overline{G}2)$. The outputs of each buffer group are enabled when $\overline{G}1$ and/or $\overline{G}2$ inputs are held low; if held high, these outputs are in a high impedance state.

The TC74HC367A is a non-inverting output type, while the TC74HC368A is an inverting output type.

All inputs are equipped with protection circuits against static discharge or transient excess voltage.

FEATURES:

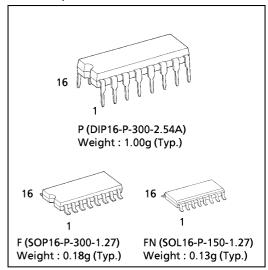
- High Speed------ t_{pd} = 11ns(typ.) at V_{CC} = 5V
- Low Power Dissipation ············· $I_{CC} = 4\mu A(Max.)$ at Ta = 25°C
- High Noise Immunity $V_{NIH} = V_{NIL} = 28\% V_{CC}$ (Min.)
- Output Drive Capability 15 LSTTL Loads
- Symmetrical Output Impedance ··· | I_{OH} | = I_{OL} = 6mA
- Balanced Propagation Delays ····· t_{pLH} ≃ t_{pHL}
- Wide Operating Voltage Range.... V_{CC} (opr.) = 2V~6V
- Pin and Function Compatible with 74LS367/368

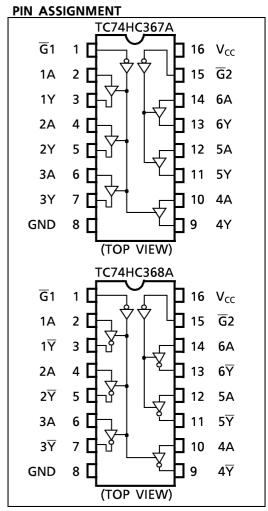
TRUTH TABLE

INP	UTS	OUTPUTS				
G	An	Y(367A)	<u>₹</u> (368A)			
L	L	L	Н			
L	Н	Н	L			
Н	Х	Z	Z			

X: Don't Care, Z: High Impedance

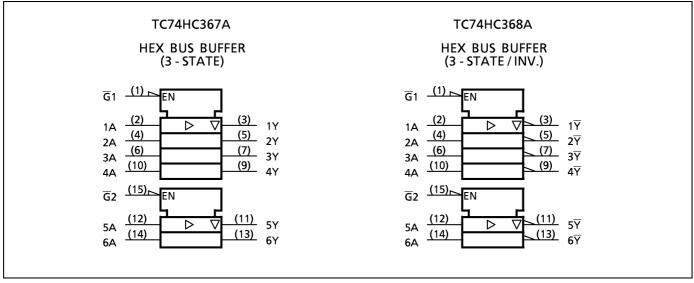
(Note) The JEDEC SOP (FN) is not available in Japan.





1

IEC LOGIC SYMBOL



ABSOLUTE MAXIMUM RATINGS

PARAMETER	SYMBOL	VALUE	UNIT
Supply Voltage Range	V _{cc}	− 0.5~7	V
DC Input Voltage	V _{IN}	$-0.5 \sim V_{CC} + 0.5$	V
DC Output Voltage	V _{OUT}	-0.5~V _{CC} +0.5	V
Input Diode Current	I _{IK}	± 20	mA
Output Diode Current	I _{OK}	± 20	mA
DC Output Current	I _{OUT}	±35	mA
DC V _{CC} / Ground Current	I _{cc}	± 75	mA
Power Dissipation	P _D	500 (DIP)* / 180 (SOP)	mW
Storage Temperature	T _{stg}	−65~150	°C

*500mW in the range of Ta= $-40^{\circ}\text{C}\sim65^{\circ}\text{C}$. From Ta=65°C to 85°C a derating factor of $-10\text{mW}/^{\circ}\text{C}$ shall be applied until 300mW.

RECOMMENDED OPERATING CONDITIONS

PARAMETER	SYMBOL	VALUE	UNIT
Supply Voltage	V _{CC}	2~6	V
Input Voltage	V _{IN}	0∼V _{cc}	V
Output Voltage	V _{OUT}	0~V _{cc}	V
Operating Temperature	T _{opr}	−40~85	°C
Input Rise and Fall Time	t _r , t _f	$0 \sim 1000 (V_{CC} = 2.0V)$ $0 \sim 500 (V_{CC} = 4.5V)$ $0 \sim 400 (V_{CC} = 6.0V)$	ns

DC ELECTRICAL CHARACTERISTICS

PARAMETER	CVMADOL	TEST	NDITION	V _{cc}		Ta = 25°C		Ta = -40~85°C		UNIT
PARAIVIETER	SYMBOL	1531 CC	MUITION	(V)	MIN.	TYP.	MAX.	MIN.	MAX.	UNIT
High - Level Input Voltage	VIH				1.50 3.15 4.20		_ _	1.50 3.15 4.20	=	>
Low - Level Input Voltage	VIL			2.0 4.5 6.0			0.50 1.35 1.80		0.50 1.35 1.80	٧
High - Level Output Voltage	V _{OH}	V _{IN} = V _{IH} or V _{IL}	$I_{OH} = -20\mu A$	2.0 4.5 6.0	1.9 4.4 5.9	2.0 4.5 6.0	_ _ _	1.9 4.4 5.9	=	V
			$I_{OH} = -6 \text{ mA}$ $I_{OH} = -7.8 \text{ mA}$	4.5 6.0	4.18 5.68	4.31 5.80	=	4.13 5.63		
Low - Level Output Voltage	$V_{OL} \qquad V_{IN} = V_{IH} \text{ or } V_{I}$	V _{I N} =	$I_{OL} = 20 \mu A$	2.0 4.5 6.0	_ _ _	0.0 0.0 0.0	0.1 0.1 0.1	_ _ _	0.1 0.1 0.1	\ \
		V _{IH} or V _{IL}	$I_{OL} = 6$ mA $I_{OL} = 7.8$ mA	4.5 6.0	_	0.17 0.18	0.26 0.26	=	0.33 0.33	
3 - State Output Off - State Current	l _{oz}	$V_{IN} = V_{IH} \text{ or } V_{IL}$ $V_{OUT} = V_{CC} \text{ or GND}$		6.0	_	_	± 0.5	_	± 5.0	
Input Leakage Current	I _{IN}	$V_{IN} = V_{CC}$ or GND		6.0	_	_	± 0.1	_	± 1.0	μ A
Quiescent Supply Current	I _{CC}	$V_{IN} = V_{CO}$	6.0	_	_	4.0	_	40.0		

3 2001-05-17

AC ELECTRICAL CHARACTERISTICS (Input $t_r = t_f = 6ns$)

PARAMETER	SYMBOL	TEST		Ta = 25°C			Ta = -40~85°C		UNIT	
FARAIVILILIN	STIVIBUL	CONDITION	CL	V _{CC} (V)	MIN.	TYP.	MAX.	MIN.	MAX.	OIVIII
	t _{TLH}			2.0	_	25	60	_	75	
Output Transition Time	t _{THL}		50	4.5 6.0	_	7 6	12 10		15 13	
	1112			2.0		36	95	_	120	-
			50	4.5	_	12	19	_	24	
Propagation Delay Time	t_{pLH}			6.0	_	10	16	_	20	
l	t _{pHL}			2.0	_	40	130	_	165	
			150	4.5	_	16	26	_	33	
				6.0 2.0		14 36	22 120		28 150	ns
	t _{pZL}	$R_L = 1k\Omega$	50	4.5	_	12	24	_	30	_
Output Enable Time				6.0	_	10	20	_	26	
Output Enable Time			150	2.0	_	40	160	_	200	
				4.5	_	16	32	_	40	
				6.0	_	14	27	_	34	
Output Disable Time	t _{pLZ}	$R_L = 1k\Omega$	50	2.0 4.5	_	35 15	120 24	_	150 30	
Output Disable Time	t _{pHZ}	NL = 1K44	30	6.0	_	13	20	_	26	
Input Capacitance	C _{IN}			•	_	5	10	_	10	
Output Capacitance	C _{OUT}				-	10	_	_	_]
		TC74HC367A		_	36	_	_	_	рF	
Power Dissipation Capacitance	C _{PD} (1)	TC74H	C368A		-	30	_	_	_	

Note (1) C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

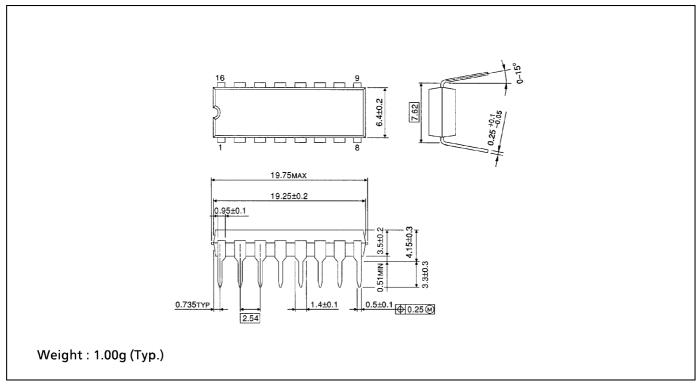
Average operating current can be obtained by the equation:

 I_{CC} (opr) = $C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC} / 6$ (per bit)

4 2001-05-17

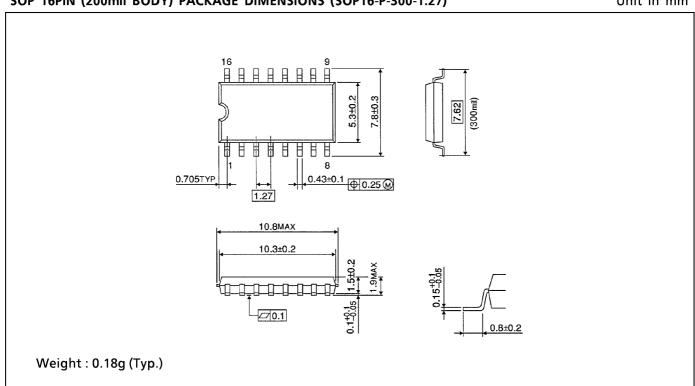
DIP 16PIN PACKAGE DIMENSIONS (DIP16-P-300-2.54A)

Unit in mm



SOP 16PIN (200mil BODY) PACKAGE DIMENSIONS (SOP16-P-300-1.27)

Unit in mm

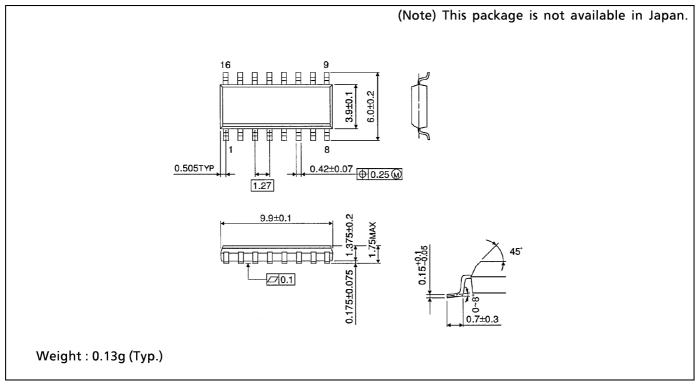


5

2001-05-17

SOP 16PIN (150mil BODY) PACKAGE DIMENSIONS (SOL16-P-150 -1.27)

Unit in mm



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7

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